

Symbol	Parameter		FQD3P50 / FQU3P50	Units
V <sub>DSS</sub>	Drain-Source Voltage		-500	V
I <sub>D</sub>	Drain Current - Continuous ( $T_C = 25^{\circ}C$ )		-2.1	А
	- Continuous (T <sub>C</sub> = 100°C	)	-1.33	А
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	-8.4	А
V <sub>GSS</sub>	Gate-Source Voltage		± 30	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy	(Note 2)	250	mJ
I <sub>AR</sub>	Avalanche Current	(Note 1)	-2.1	А
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	5.0	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	-4.5	V/ns
P <sub>D</sub>	Power Dissipation (T <sub>A</sub> = 25°C) *		2.5	W
	Power Dissipation ( $T_C = 25^{\circ}C$ )		50	W
	- Derate above 25°C		0.4	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C
TL	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

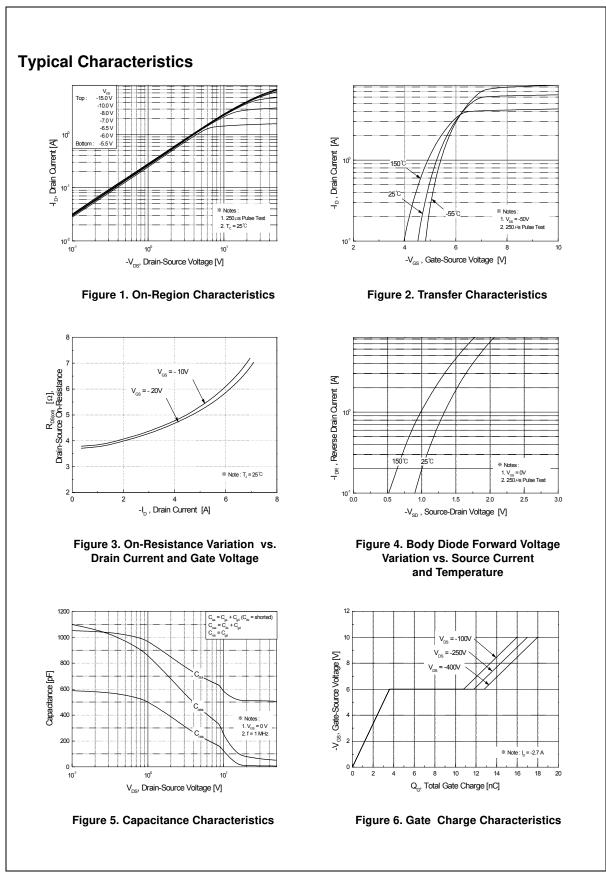
# **Thermal Characteristics**

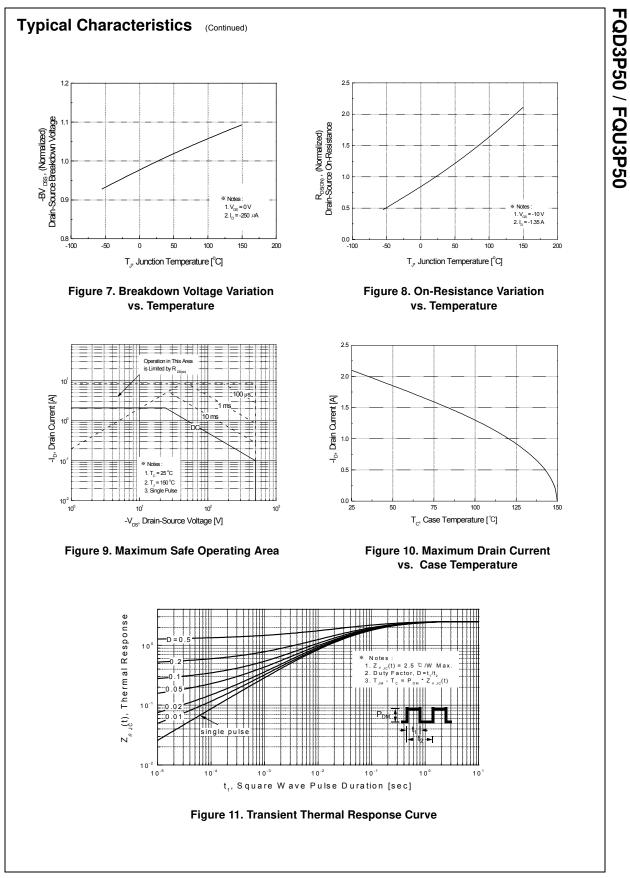
Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		2.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		50	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		110	°C/W

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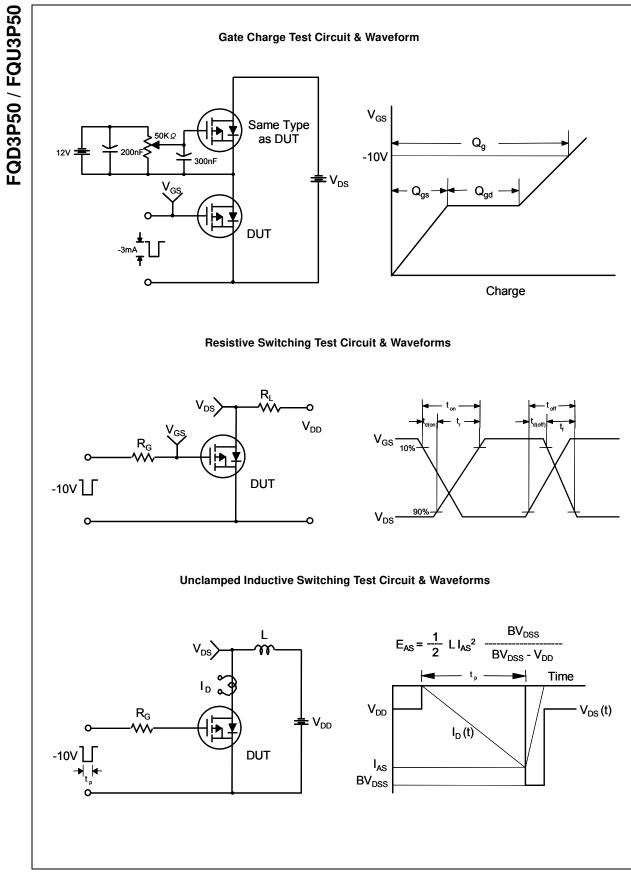
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Cha	iracteristics					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = -250 μA	-500			V
ΔBV <sub>DSS</sub> ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	$I_D$ = -250 µA, Referenced to 25°C		0.42		V/°C
I <sub>DSS</sub>	Zara Cata Maltana Duain Comunit	$V_{DS}$ = -500 V, $V_{GS}$ = 0 V			-1	μA
	Zero Gate Voltage Drain Current	V <sub>DS</sub> = -400 V, T <sub>C</sub> = 125°C			-10	μA
GSSF	Gate-Body Leakage Current, Forward	V <sub>GS</sub> = -30 V, V <sub>DS</sub> = 0 V			-100	nA
GSSR	Gate-Body Leakage Current, Reverse	$V_{GS}$ = 30 V, $V_{DS}$ = 0 V			100	nA
)n Cha	racteristics					
/ <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-3.0		-5.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	$V_{GS} = -10 \text{ V}, \text{ I}_{D} = -1.05 \text{ A}$		3.9	4.9	Ω
FS	Forward Transconductance	V <sub>DS</sub> = -50 V, I <sub>D</sub> = -1.05 A (Note 4)		2.1		S
Dynami Diss	ic Characteristics			510	660	pF
oss	Output Capacitance	V <sub>DS</sub> = -25 V, V <sub>GS</sub> = 0 V, f = 1 0 MHz		70	90	pr pF
Poss Prss	Reverse Transfer Capacitance			9.5	12	pF
d(on)	Turn-On Delay Time Turn-On Rise Time	$V_{DD} = -250 \text{ V}, \text{ I}_{D} = -2.7 \text{ A},$		12 56	35 120	ns ns
d(off)	Turn-Off Delay Time	R <sub>G</sub> = 25 Ω		35	80	ns
-	Turn-Off Fall Time	(Note 4, 5)		45	100	ns
λ <sup>g</sup>	Total Gate Charge	V <sub>DS</sub> = -400 V, I <sub>D</sub> = -2.7 A,		18	23	nC
ي ک <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> = -10 V		3.6		nC
λ <sup>gd</sup>	Gate-Drain Charge	(Note 4, 5)		9.2		nC
Drain-S	ource Diode Characteristics a	nd Maximum Ratings				
3	Maximum Continuous Drain-Source Die				-2.1	Α
SM	Maximum Pulsed Drain-Source Diode F	Forward Current			-8.4	Α
/ <sub>SD</sub>	Drain-Source Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = -2.1 A			-5.0	V
т	Reverse Recovery Time	V <sub>GS</sub> = 0 V, I <sub>S</sub> = -2.7 A,		270		ns
۵ <sup>س</sup>	Reverse Recovery Charge	$dI_{F} / dt = 100 A/\mu s$ (Note 4)		1.5		μC
_ = 102mH, <sub>SD</sub> ≤ -2.7A, Pulse Test :	ating : Pulse width limited by maximum junction tempe $I_{AS} = -2.1A, V_{DD} = -50V, R_G = 25 \Omega, Starting T_J = 25^{\circ}$ di/dt $\leq 200A/\mu_s, V_{DD} \leq BV_{DSS}$ Starting T_J = 25°C Pulse width $\leq 300\mu_s$ , Duty cycle $\leq 2\%$ dependent of operating temperature					



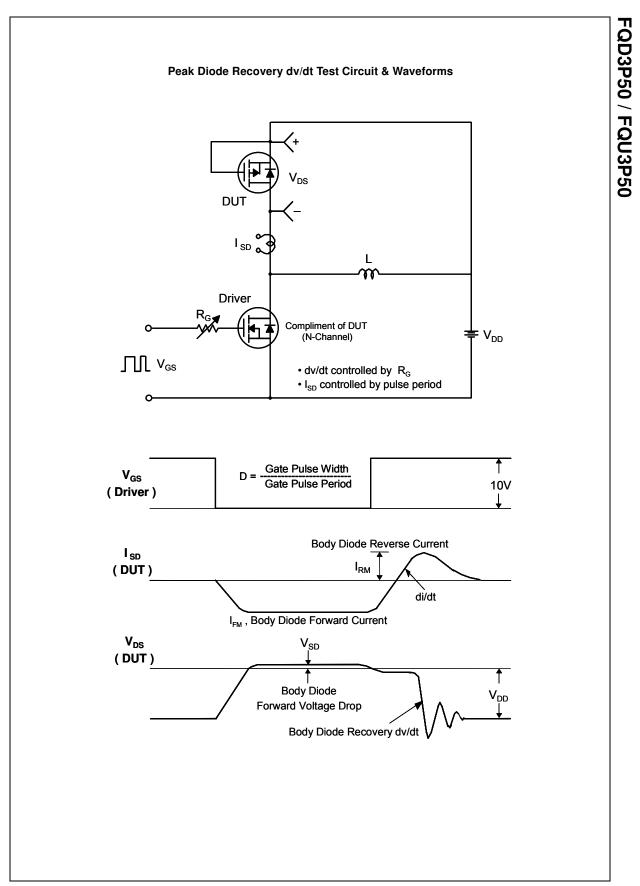




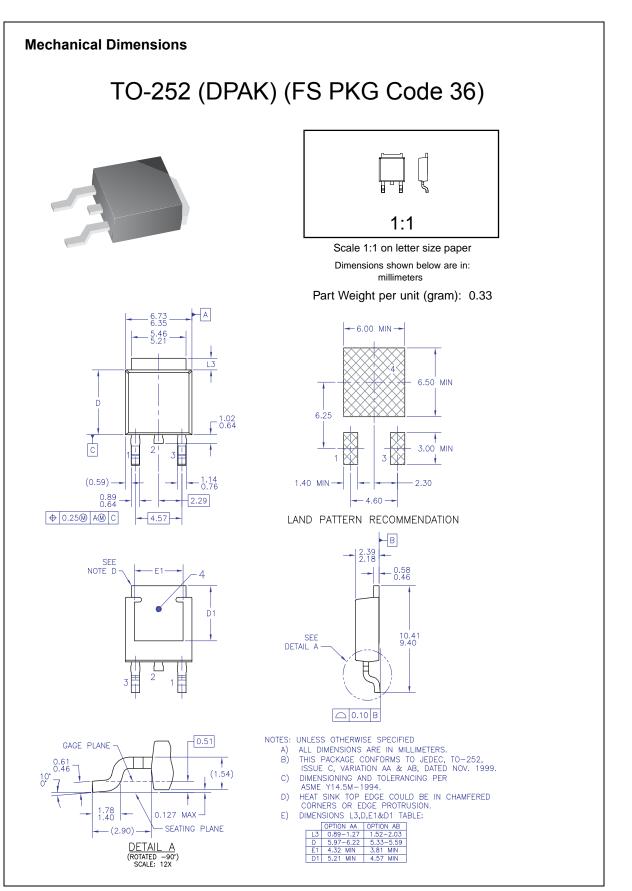
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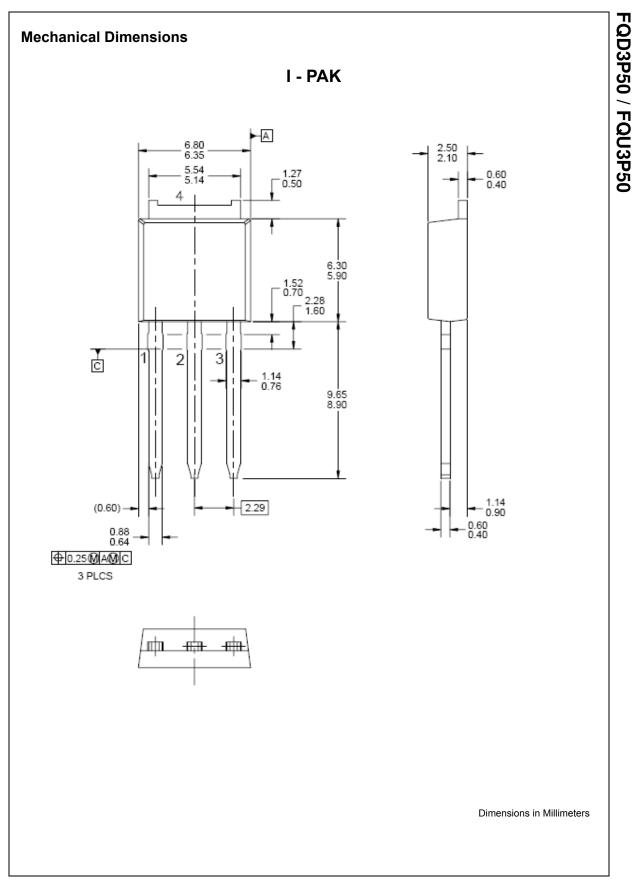
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FQD3P50 / FQU3P50



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